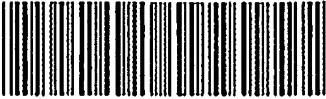


Search Notes		Application/Control No.	Applicant(s)/Patent under Reexamination
		10/634,747	SESSER ET AL.
		Examiner	Art Unit
		Dinh Q. Nguyen	3752

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Class	Subclass	Date	Examiner
239	204		
214.17			
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222.11			
222.15			
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232			
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247	3-21-05	QJ	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST SEARCH ATTACHED REF 09/818, 275 10/119, 294	3-21-05	QJ
UPDATED EAST SEARCH ATTACHED		8-03-05 QJ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner